

Contents

- RF measurement methods some history and overview
- Voltage Standing Wave Ratio (VSWR)
- Introduction to Scattering-parameters (S-parameters)
- Properties of the S matrix of an N-port (N=1...4) and examples
- Smith Chart and its applications
- Appendices

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

Measurement methods - overview (1)

There are many ways to observe RF signals. Here we give a brief overview of the four main tools we have at hand

- Oscilloscope: to observe signals in time domain
 - periodic signals
 - burst signal
 - application: direct observation of signal from a pick-up, shape of common 230 V mains supply voltage, etc.
- Spectrum analyser: to observe signals in frequency domain
 - sweeps through a given frequency range point by point
 - application: observation of spectrum from the beam or of the spectrum emitted from an antenna, etc.

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

3

Measurement methods - overview (2)

- Dynamic signal analyser (FFT analyser)
 - Acquires signal in time domain by fast sampling
 - Further numerical treatment in digital signal processors (DSPs)
 - Spectrum calculated using Fast Fourier Transform (FFT)
 - Combines features of a scope and a spectrum analyser: signals can be looked at directly in time domain or in frequency domain
 - Contrary to the SPA, also the spectrum of non-repetitive signals and transients can be observed
 - Application: Observation of tune sidebands, transient behaviour of a phase locked loop, etc.
- Coaxial measurement line
 - old fashion metchod no more in use but good for understanding of concept
- Network analyser
 - Excites a network (circuit, antenna, amplifier or simmilar) at a given CW frequency and measures response in magnitude and phase => determines S-parameters
 - Covers a frequency range by measuring step-by-step at subsequent frequency points
 - Application: characterization of passive and active components, time domain reflectometry by Fourier transforming reflection response, etc.

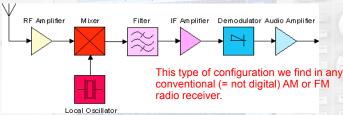
CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

Superheterodyne Concept (1)

Design and its evolution

The diagram below shows the basic elements of a single conversion superhet receiver. The essential elements of a local oscillator and a mixer followed by a fixed-tuned filter and IF amplifier are common to all superhet circuits. [super $\epsilon \tau \epsilon \rho \omega \delta \nu \alpha \mu \iota \sigma$] a mixture of latin and greekit/// means: another force becomes superimposed.



The advantage to this method is that most of the radio's signal path has to be sensitive to only a narrow range of frequencies. Only the front end (the part before the frequency converter stage) needs to be sensitive to a wide frequency range. For example, the front end might need to be sensitive to 1–30 MHz, while the rest of the radio might need to be sensitive only to 455 kHz, a typical IF. Only one or two tuned stages need to be adjusted to track over the tuning range of the receiver; all the intermediate-frequency stages operate at a fixed frequency which need not be adjusted.

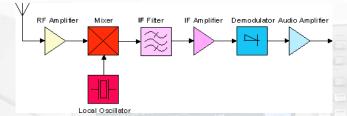
en.wikipedia.org

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

-

Superheterodyne Concept (2)



RF Amplifier = wideband frontend amplification (RF = radio frequency)

The Mixer can be seen as an analog multiplier which multiplies the RF signal with the LO (local oscillator) signal.

The local oscillator has its name because it's an oscillator situated in the receiver locally and not far away as the radio transmitter to be received.

IF stands for intermediate frequency.

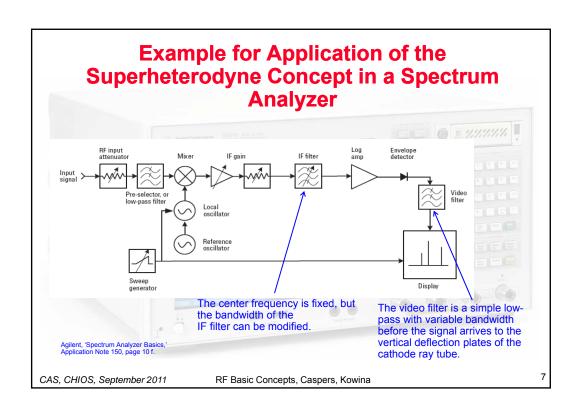
The demodulator can be an amplitude modulation (AM) demodulator (envelope detector) or a frequency modulation (FM) demodulator, implemented e.g. as a PLL (phase locked loop).

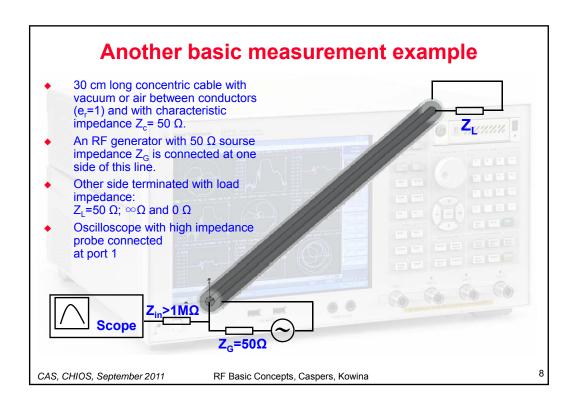
The tuning of a normal radio receiver is done by changing the frequency of the LO, not of the IF filter.

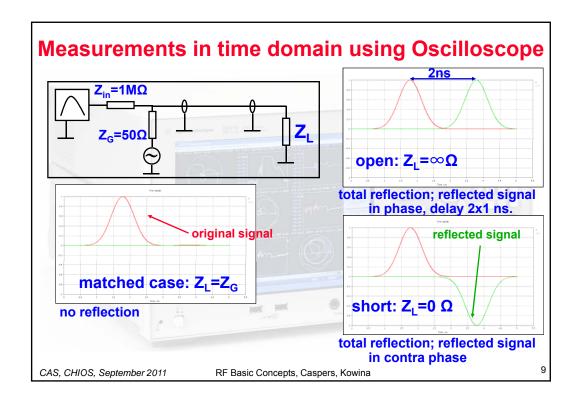
en.wikipedia.org

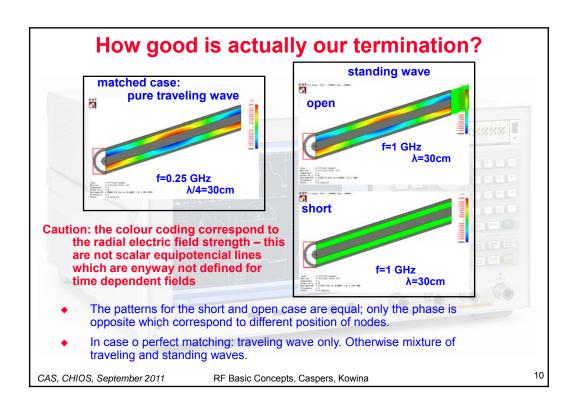
CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina







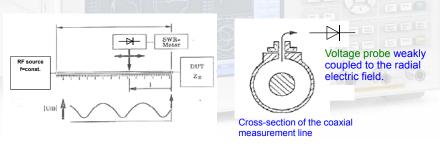


Voltage Standing Wave Ratio (1)

Origin of the term "VOLTAGE Standing Wave Ratio – VSWR":

In the old days when there were no Vector Network Analyzers available, the reflection coefficient of some DUT (device under test) was determined with the coaxial measurement line.

Coaxial measurement line: coaxial line with a narrow slot (slit) in length direction. In this slit a small voltage probe connected to a crystal detector (detector diode) is moved along the line. By measuring the ratio between the maximum and the minimum voltage seen by the probe and the recording the position of the maxima and minima the reflection coefficient of the DUT at the end of the line can be determined.



CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

Voltage Standing Wave Ratio (2)

VOLTAGE DISTRIBUTION ON LOSSLESS TRANSMISSION LINES

For an ideally terminated line the magnitude of voltage and current are constant along the line, their phase vary linearly.

In presence of a notable load reflection the voltage and current distribution along a transmission line are no longer uniform but exhibit characteristic ripples. The phase pattern resembles more and more to a staircase rather than a ramp.

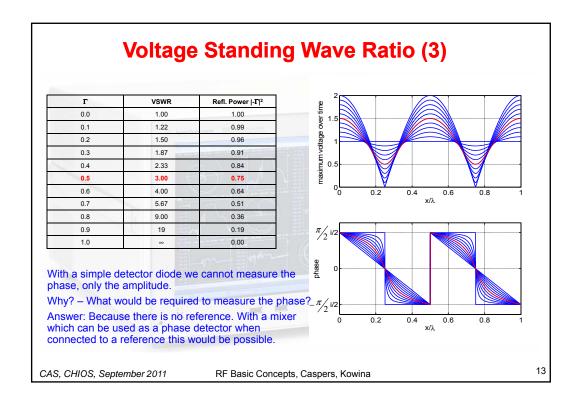
A frequently used term is the "Voltage Standing Wave Ratio VSWR" that gives the ratio between maximum and minimum voltage along the line. It is related to load reflection by the expression

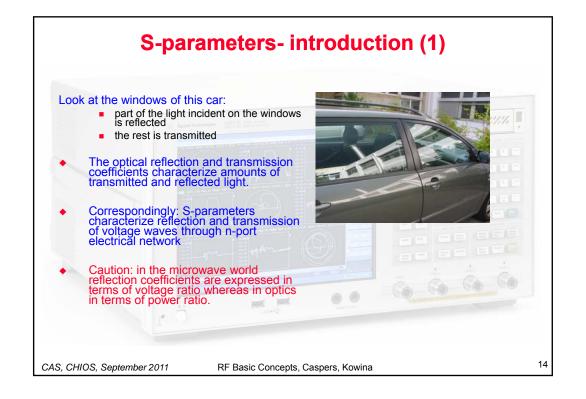
$$\begin{aligned} V_{\text{max}} &= \left| a \right| + \left| b \right| \\ V_{\text{min}} &= \left| a \right| - \left| b \right| \end{aligned} \qquad VSWR = \frac{V_{\text{max}}}{V_{\text{min}}} = \frac{\left| a \right| + \left| b \right|}{\left| a \right| - \left| b \right|} = \frac{1 + \left| \Gamma \right|}{1 - \left| \Gamma \right|} \end{aligned}$$

Remember: the reflection coefficient Γ is defined via the **ELECTRIC FIELD** of the incident and reflected wave. This is historically related to the measurement method described here. We know that an open has a reflection coefficient of Γ =+1 and the short of Γ =-1. When referring to the magnetic field it would be just opposite.

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina



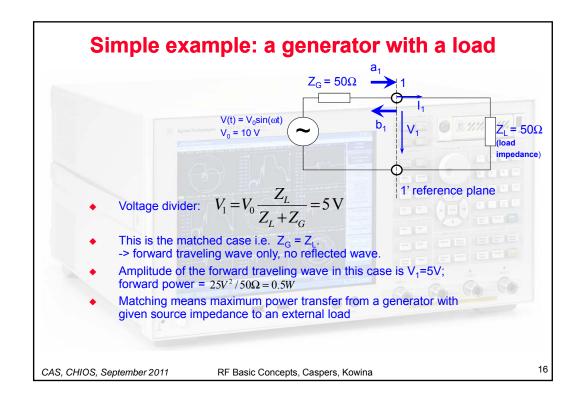


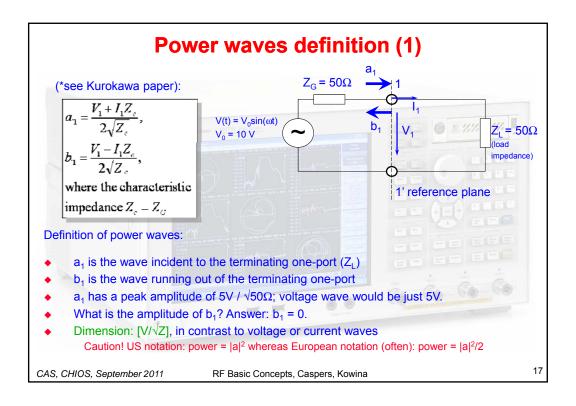
S-parameters- introduction (2) When the linear dimmensions of an object approche one tenth of the (free space) wavelength this circuit can not be modeled precisely anymore with the single lumped element. Kurokawa in 1965 introduced "power waves" instead of voltage and current waves used so far K. Kurokawa, "Power Waves and the Scattering Matrix," [EEE Transactions on Microwave Theory and Techniques, Vol. MTT-13, No. 2, March, 1965. The essencial difference between power wave and current wave is a

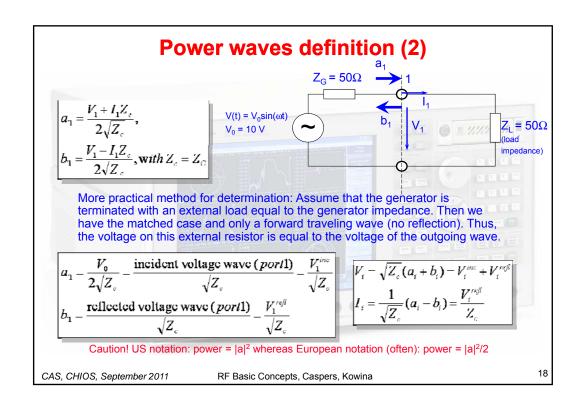
- The essencial difference between power wave and current wave is a normalisation to square root of characteristic impedance √Z_c
- The abbreviation S has been derived from the word scattering.
- Since S-parameters are defined based on traveling waves
 -> the absolute value (modulus) does not vary along a lossless transmissions line
 -> they can be measured on a DUT (Device Under Test) situated at some distance from an S-parameter measurement instrument (like Network Analyser)
- How are the S-parameters defined?

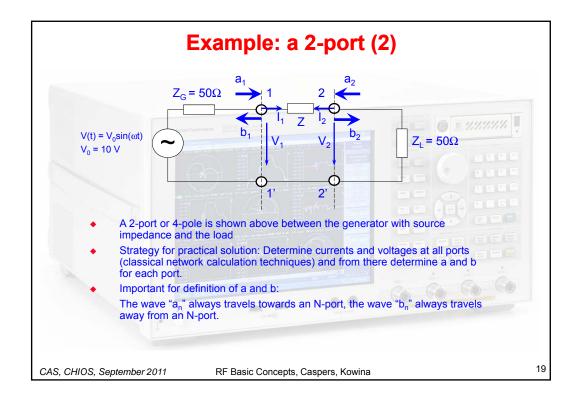
CAS, CHIOS, September 2011

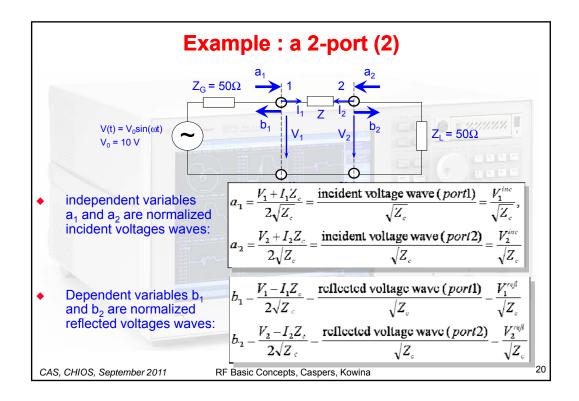
RF Basic Concepts, Caspers, Kowina











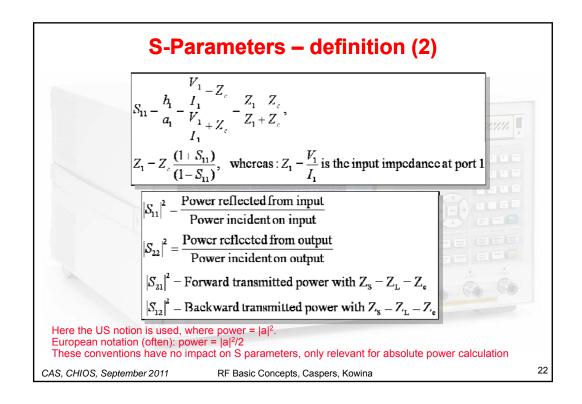
S-Parameters – definition (1)

The linear equations decribing two-port network are:
$$b_1 = S_{11}a_1 + S_{12}a_2$$
 $b_2 = S_{22}a_2 + S_{21}a_2$
The S-parameters S_{11} , S_{22} , S_{21} , S_{12} are given by:

$$\begin{vmatrix}
S_{11} - \frac{b_1}{a_1} | \\ a_2 - 0
\end{vmatrix} = \text{Input reflection coeff.} (Z_L - Z_e \rightarrow a_2 - 0)$$

$$\begin{vmatrix}
S_{22} - \frac{b_2}{a_1} | \\ a_2 = 0
\end{vmatrix} = \text{Porward transmiss ion gain}$$

$$\begin{vmatrix}
S_{12} - \frac{b_1}{a_1} | \\ a_2 = 0
\end{vmatrix} = \text{Backward transmiss ion gain}$$
CAS, CHIOS, September 2011 RF Basic Concepts, Caspers, Kowina 21



The Scattering-Matrix (1)

Waves traveling towards the n-port: $(a) = (a_1, a_2, a_3, \dots a_n)$ Waves traveling away from the n-port: $(b) = (b_1, b_2, b_3, \dots b_n)$

The relation between a_i and b_i (i = 1..n) can be written as a **system of n linear equations** (a_i = the independent variable, b_i = the dependent variable):

one - port $b_1 = S_{11}a_1 + S_{12}a_2 + S_{13}a_3 + S_{14}a_4 + \dots$ two - port $b_2 = S_{21}a_1 + S_{22}a_2 + S_{23}a_3 + S_{44}a_4 + \dots$ three - port $b_3 = S_{31}a_1 + S_{32}a_2 + S_{33}a_3 + S_{44}a_4 + \dots$ four - port $b_4 = S_{41}a_1 + S_{42}a_2 + S_{33}a_3 + S_{44}a_4 + \dots$

In compact matrix notation, these equations can also be written as:

$$(b) = (S)(a)$$

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

23

The Scattering Matrix (2)

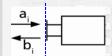
The simplest form is a passive **one-port** (2-pole) with some reflection coefficient Γ .

$$(S) = S_{11} \quad \rightarrow \quad b_1 = S_{11}a_1$$

With the reflection coefficient Γ it follows that

$$S_{11} = \frac{b_1}{a_1} = \Gamma$$

Reference plane

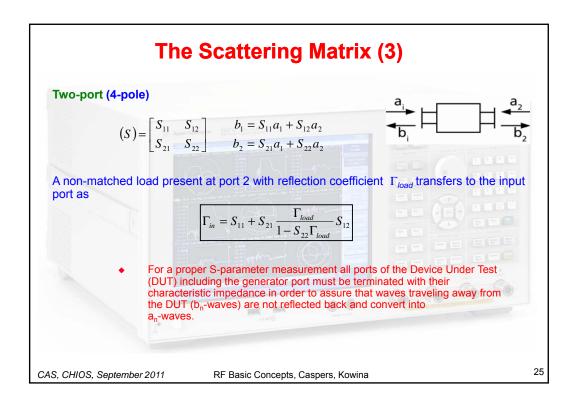


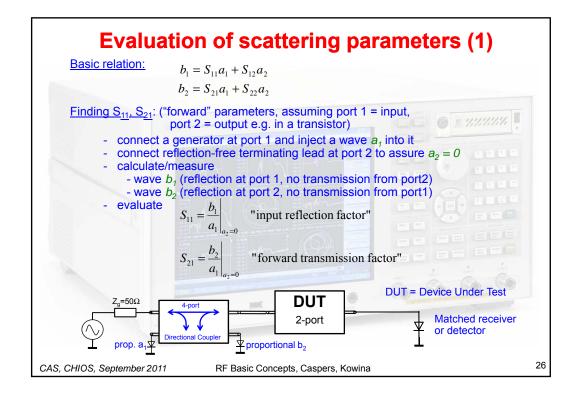
What is the difference between Γ and S11 or S22?

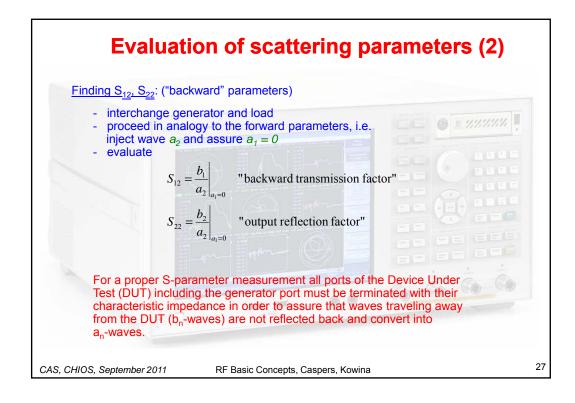
- On the contrary, for a proper S-parameter measurement all ports of the Device Under Test (DUT) including the generator port must be terminated with their characteristic impedance in order to assure that waves traveling away from the DUT (b_n-waves) are not reflected back and convert into a_n-waves.

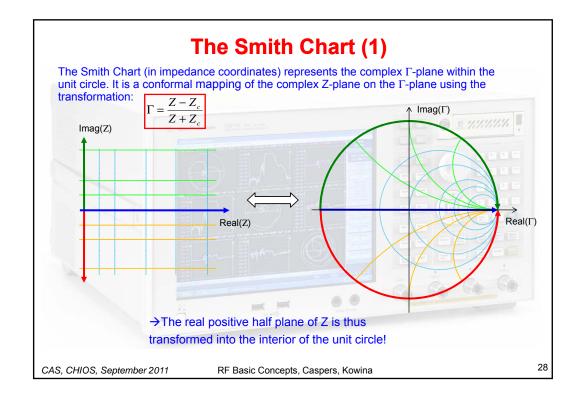
CAS, CHIOS, September 2011

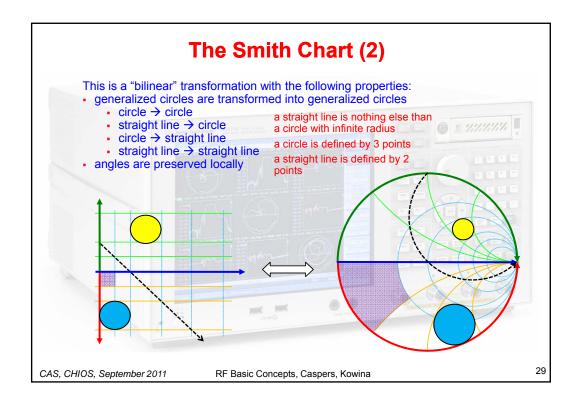
RF Basic Concepts, Caspers, Kowina











The Smith Chart (3)

Impedances Z are usually first normalized by $z = \frac{Z}{Z}$

where Z_0 is some characteristic impedance (e.g. 50 Ohm). The general form of the transformation can then be written as

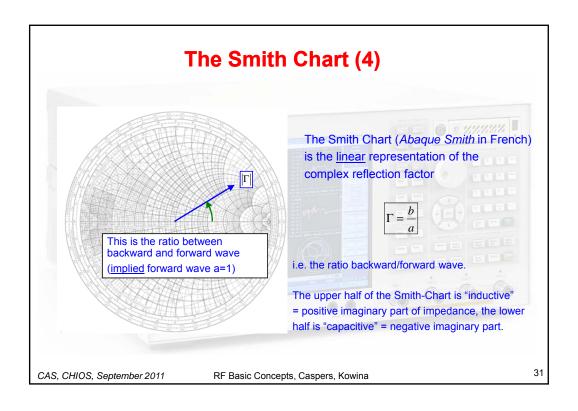
$$\Gamma = \frac{z-1}{z+1}$$
 resp. $z = \frac{1+\Gamma}{1-\Gamma}$

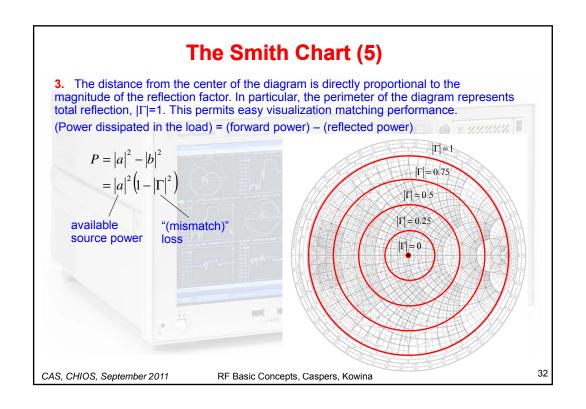
This mapping offers several practical advantages:

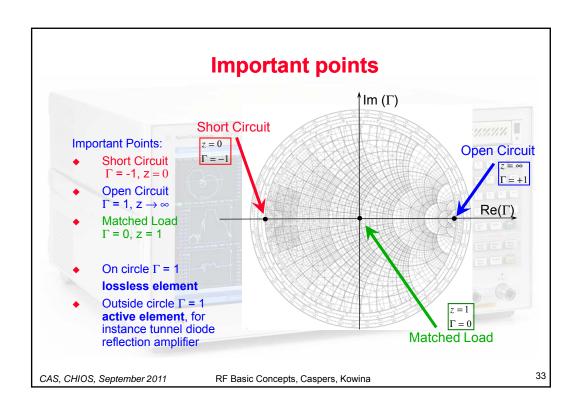
- 1. The diagram includes all "passive" impedances, i.e. those with positive real part, from zero to infinity in a handy format. Impedances with negative real part ("active device", e.g. reflection amplifiers) would be outside the (normal) Smith chart.
- 2. The mapping converts impedances or admittances into reflection factors and vice-versa. This is particularly interesting for studies in the radiofrequency and microwave domain where electrical quantities are usually expressed in terms of "direct" or "forward" waves and "reflected" or "backward" waves. This replaces the notation in terms of currents and voltages used at lower frequencies. Also the reference plane can be moved very easily using the Smith chart.

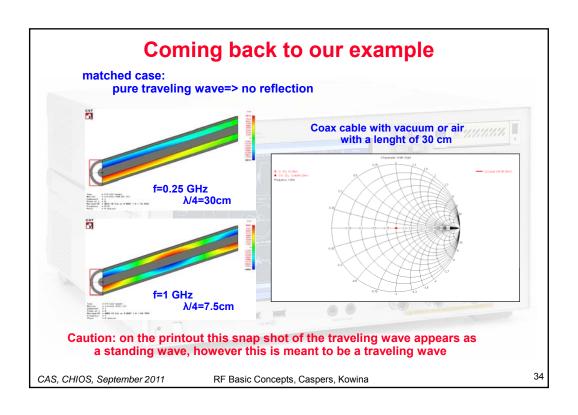
CAS, CHIOS, September 2011

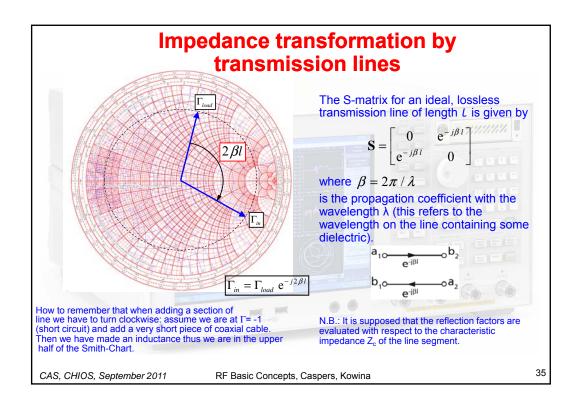
RF Basic Concepts, Caspers, Kowina

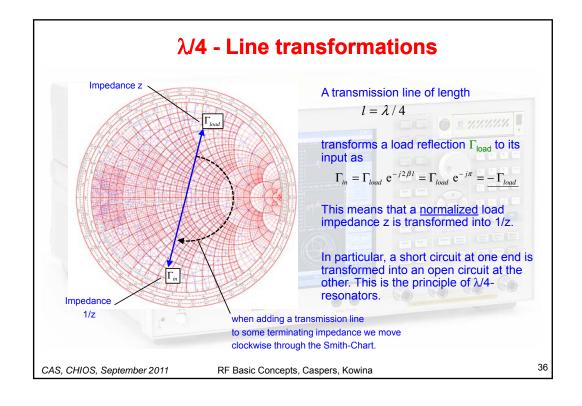


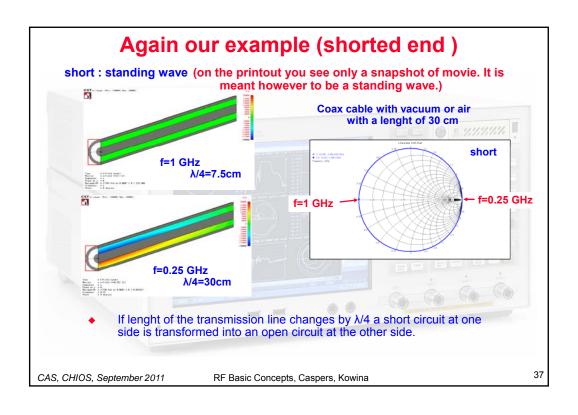


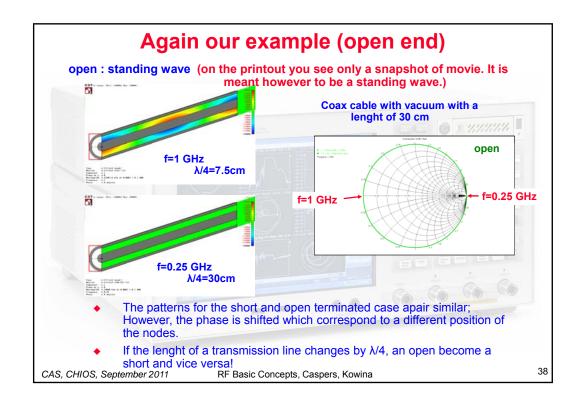
















Photos from RF-Lab CAS 2009, Darmstadt

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

39

Measurements using Spectrum Analyzer and oscilloscope (1)

- Measurements of several types of modulation (AM, FM, PM) in the time-domain and frequency-domain.
- Superposition of AM and FM spectrum (unequal height side bands).
- Concept of a spectrum analyzer: the superheterodyne method. Practice all the different settings (video bandwidth, resolution bandwidth etc.). Advantage of FFT spectrum analyzers.
- Measurement of the RF characteristic of a microwave detector diode (output voltage versus input power... transition between regime output voltage proportional input power and output voltage proportional input voltage); i.e. transition between square low and linear region.
- Concept of noise figure and noise temperature measurements, testing a noise diode, the basics of thermal noise.
- Noise figure measurements on amplifiers and also attenuators.
- The concept and meaning of ENR (excess noise ratio) numbers.

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

Measurements using Spectrum Analyzer and oscilloscope (2)

- EMC measurements (e.g.: analyze your cell phone spectrum).
- Noise temperature of the fluorescent tubes in the RF-lab using a satellite receiver.
- Measurement of the IP3 (intermodulation point of third order) on some amplifiers (intermodulation tests).
- Nonlinear distortion in general; Concept and application of vector spectrum analyzers, spectrogram mode (if available).
- Invent and design your own experiment!

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

4

Measurements using Vector Network Analyzer (1)

- N-port (N=1...4) S-parameter measurements on different reciprocal and non-reciprocal RF-components.
- Calibration of the Vector Network Analyzer.
- Navigation in The Smith Chart.
- Application of the triple stub tuner for matching.
- ◆ Time Domain Reflectomentry using synthetic pulse →direct measurement of coaxial line characteristic impedance.
- Measurements of the light velocity using a trombone (constant impedance adjustable coax line).
- 2-port measurements for active RF-components (amplifiers):
 1 dB compression point (power sweep).
- Concept of EMC measurements and some examples.

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

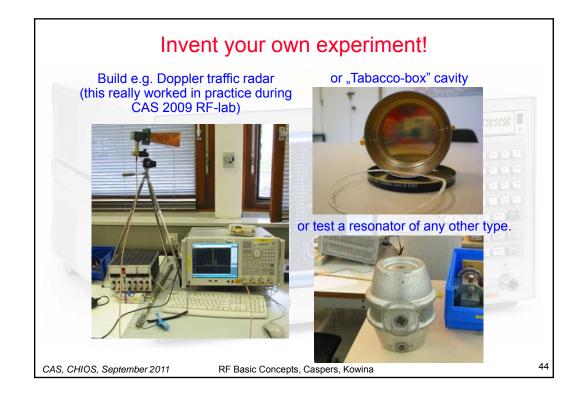
Measurements using Vector Network Analyzer (2)

- Measurements of the characteristic cavity properties (Smith Chart analysis).
- Cavity perturbation measurements (bead pull).
- Beam coupling impedance measurements with the wire method (some examples).
- Beam transfer impedance measurements with the wire (button PU, stripline PU.)
- Self made RF-components: Calculate build and test your own attenuator in a SUCO box (and take it back home then).
- Invent and design your own experiment!

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina

4







Appendix A: Definition of the Noise Figure

$$F = \frac{S_i / N_i}{S_o / N_o} = \frac{N_o}{GN_i} = \frac{N_o}{GkT_0B} = \frac{GN_i + N_R}{GkT_0B} = \frac{GkT_0B + N_R}{GkT_0B}$$

- ◆ F is the Noise factor of the receiver
- ◆ S_i is the available signal power at input
- $N_i = kT_0B$ is the available noise power at input
- \bullet T_0 is the absolute temperature of the source resistance
- N_o is the available noise power at the output, including amplified input noise
- N_r is the noise added by receiver
- G is the available receiver gain
- ♦ B is the effective noise bandwidth of the receiver
- ♦ If the noise factor is specified in a logarithmic unit, we use the term Noise Figure (NF)

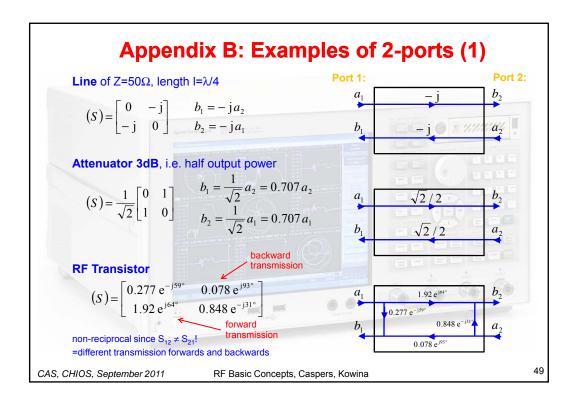
 $NF = 10\lg \frac{S_i / N_i}{S_o / N_o} dB$

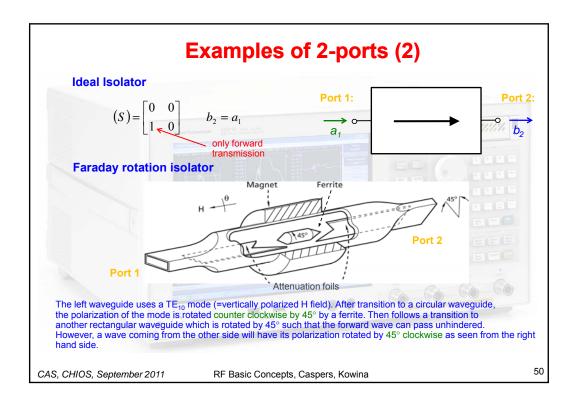
CAS, CHIOS, September 2011

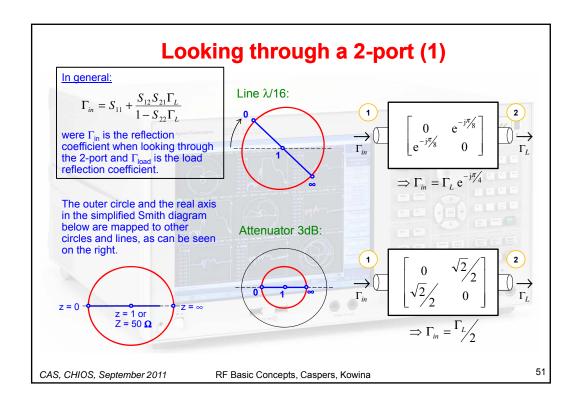
CAS, CHIOS, September 2011

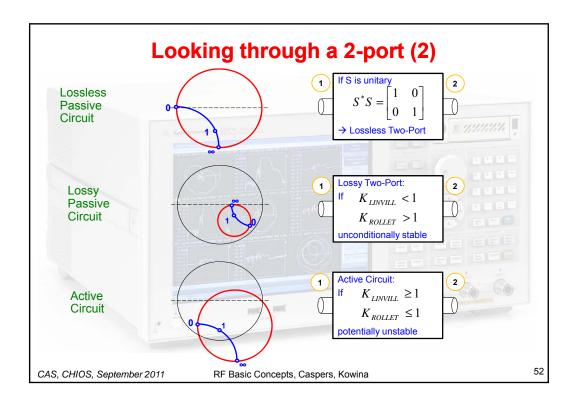
RF Basic Concepts, Caspers, Kowina

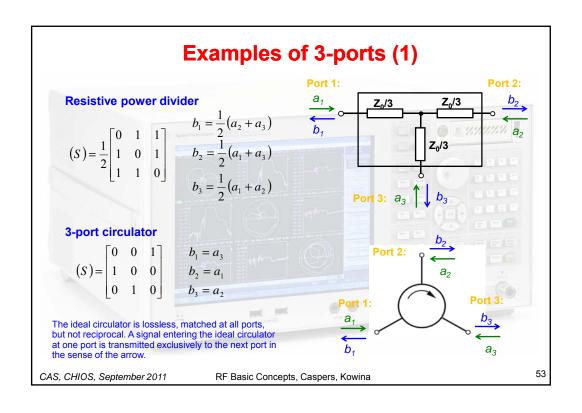
RF Basic Concepts, Caspers, Kowina

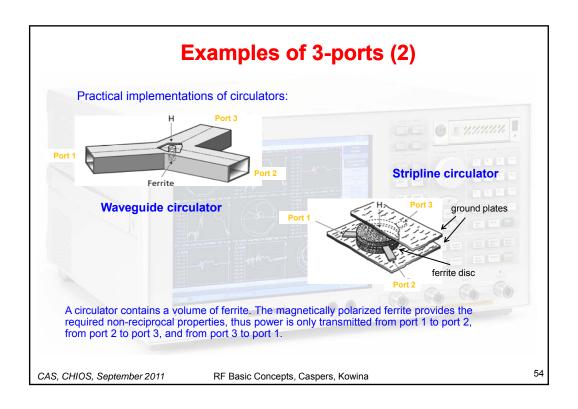












Examples of 4-ports (1)

Ideal directional coupler

$$(S) = \begin{bmatrix} 0 & jk & \sqrt{1-k^2} & 0 \\ jk & 0 & 0 & \sqrt{1-k^2} \\ \sqrt{1-k^2} & 0 & 0 & jk \\ 0 & \sqrt{1-k^2} & jk & 0 \end{bmatrix} \text{ with } k = \begin{vmatrix} b_2 \\ a_1 \end{vmatrix}$$

To characterize directional couplers, three important figures are used:

the coupling $C = -20 \log_{10} \frac{b_2}{a_1}$

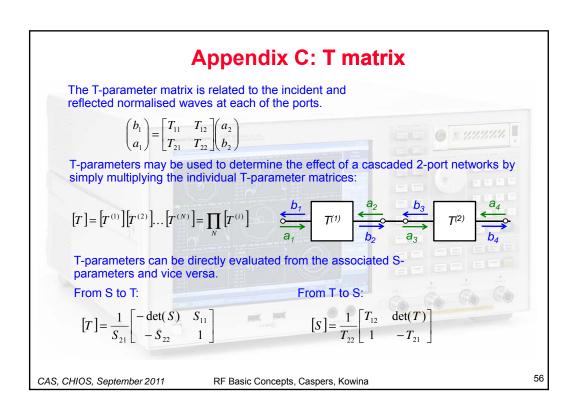
the directivity $D = -20 \log_{10} \frac{b_2}{b_2}$

the isolation $D = -20 \log_{10} \frac{a_1}{b_2}$

Coupled Isolated

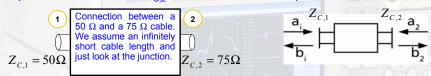
CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina



Appendix D: A Step in Characteristic Impedance (1)

Consider a connection of two coaxial cables, one with $Z_{C,1}$ = 50 Ω characteristic impedance, the other with $Z_{C,2}$ = 75 Ω characteristic impedance.



Step 1: Calculate the reflection coefficient and keep in mind: all ports have to be terminated with their respective characteristic impedance, i.e. 75 Ω for port 2.

$$\Gamma_1 = \frac{Z - Z_{C,1}}{Z + Z_{C,1}} = \frac{75 - 50}{75 + 50} = 0.2$$

Thus, the voltage of the reflected wave at port 1 is 20% of the incident wave and the reflected power at port 1 (proportional Γ^2) is $0.2^2 = 4\%$. As this junction is lossless, the transmitted power must be 96% (conservation of energy). From this we can deduce $b_2^2 = 0.96$. But: how do we get the voltage of this outgoing wave?

CAS, CHIOS, September 2011

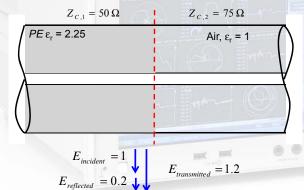
RF Basic Concepts, Caspers, Kowina

57



Step 2: Remember, a and b are power-waves and defined as voltage of the forward- or backward traveling wave normalized to $\sqrt{Z_c}$.

The tangential electric field in the dielectric in the 50 Ω and the 75 Ω line, respectively, must be continuous.



t = voltage transmission coefficient $t = 1 + \Gamma$ in this case.

This is counterintuitive, one might expect 1-Γ. Note that the voltage of the transmitted wave is higher than the voltage of the incident wave. But we have to normalize to $\sqrt{z_c}$ to get the corresponding S-parameter. $S_{12} = S_{21}$ via reciprocity! But $S_{11} \neq S_{22}$, i.e. the structure is NOT symmetric.

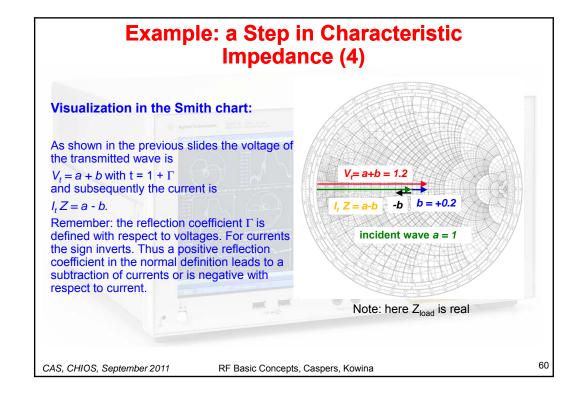
CAS, CHIOS, September 2011

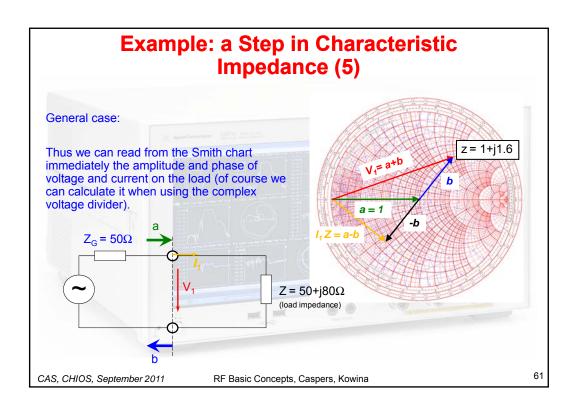
RF Basic Concepts, Caspers, Kowina

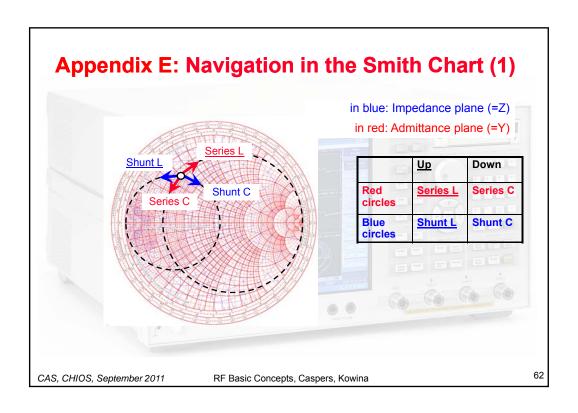
Example: a Step in Characteristic impedance (3)

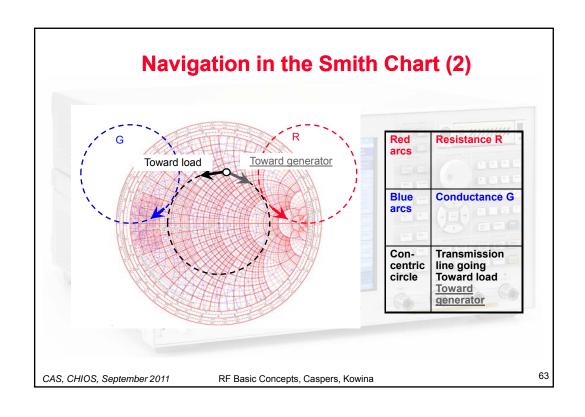
Once we have determined the voltage transmission coefficient, we have to normalize to the ratio of the characteristic impedances, respectively. Thus we get for
$$S_{12}=1.2\sqrt{\frac{50}{75}}=1.2\cdot0.816=0.9798$$
We know from the previous calculation that the reflected power (proportional Γ^2) is 4% of the incident power. Thus 96% of the power are transmitted. Check done $S_{12}{}^2=1.44\frac{1}{1.5}=0.96=(0.9798)^2$

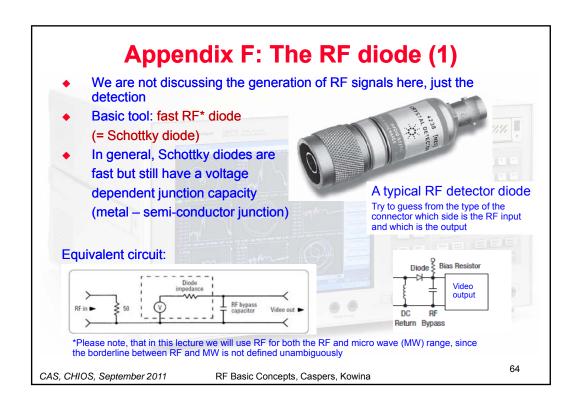
$$S_{22}=\frac{50-75}{50+75}=-0.2 \text{ To be compared with S11}=+0.2!$$
CAS, CHIOS, September 2011 RF Basic Concepts, Caspers, Kowina

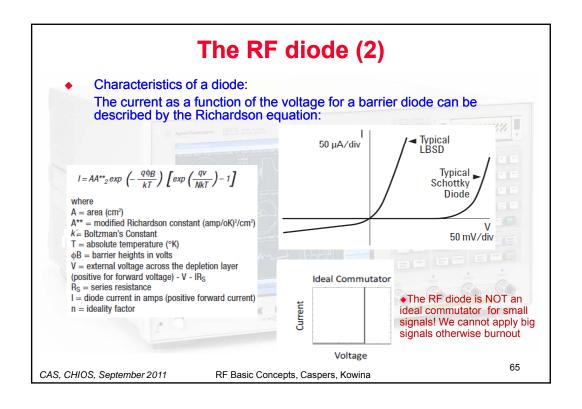


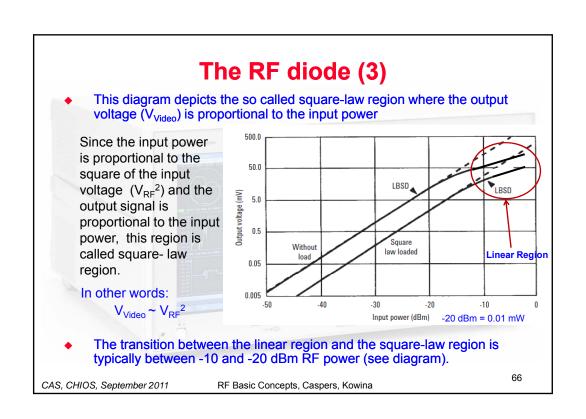


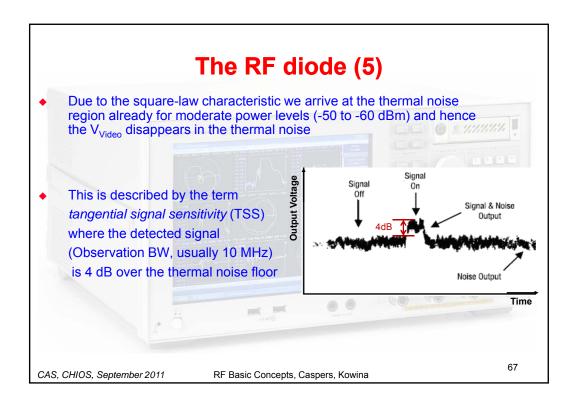






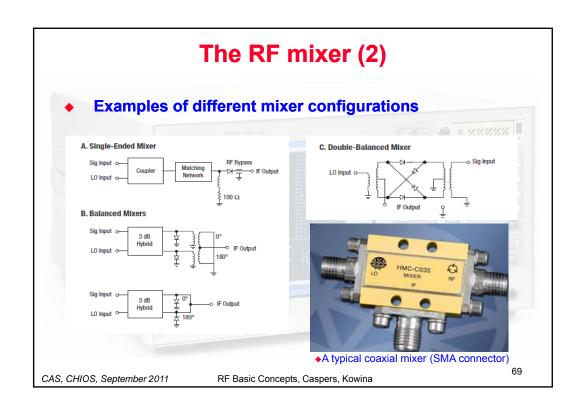


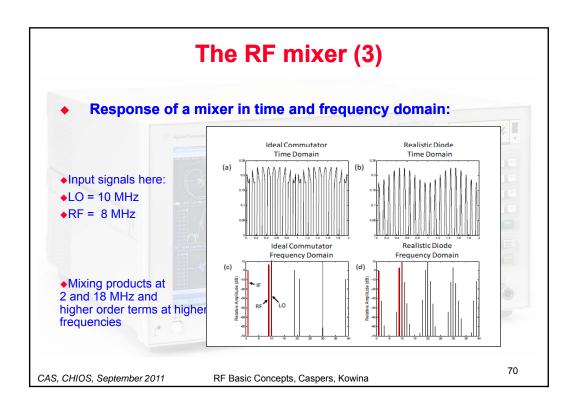




RF Basic Concepts, Caspers, Kowina

CAS, CHIOS, September 2011

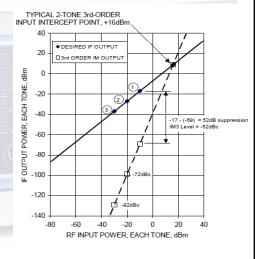




The RF mixer (4)

Dynamic range and IP3 of an RF mixer

- The abbreviation IP3 stands for the third order intermodulation point where the two lines shown in the right diagram intersect. Two signals (f₁,f₂ > f₁) which are closely spaced by Δf in frequency are simultaneously applied to the DUT. The intermodulation products appear at + Δf above f₂ and at Δf below f₁.
- This intersection point is usually not measured directly, but extrapolated from measurement data at much smaller power levels in order to avoid overload and damage of the DUT.



71

CAS, CHIOS, September 2011

RF Basic Concepts, Caspers, Kowina